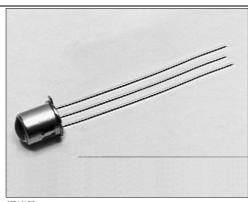
Optoschmitt Detector

FEATURES

- TO-46 metal can package
- 6° (nominal) acceptance angle
- · High noise immunity output
- TTL/LSTTL/CMOS compatible
- Buffer (SD5600) or inverting (SD5610) logic available
- Mechanically and spectrally matched to SE3450/5450, SE3455/5455 and SE3470/5470 infrared emitting diodes



DESCRIPTION

The SD5600/5610 series is a family of single chip Optoschmitt IC detectors mounted in a TO-46 metal can package. The photodetector consists of a photodiode, amplifier, voltage regulator, Schmitt trigger and an NPN output transistor with 10 $k\Omega$ (nominal) pull-up resistor. Output rise and fall times are independent of the rate of change of incident light. Detector sensitivity has been internally temperature compensated. The TO-46 package is ideally suited for operation in hostile environments

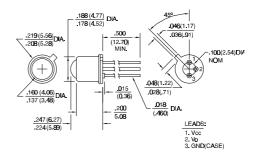
Device Polarity:

Output is HI when incident light intensity is above the turn- on threshold level.

Inverter - Output is LO when incident light intensity is above the turn- on threshold level.

OUTLINE DIMENSIONS in inches (mm)

3 plc decimals ±0.005(0.12) 2 plc decimals ±0.020(0.51)



DIM_025.cdr



Optoschmitt Detector

ELECTRICAL CHARACTERISTICS (-40°C to +100°C unless otherwise noted)

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	TEST CONDITIONS
Operating Supply Voltage	Vcc	4.5		16.0	V	T _A =25°C
Turn-on Threshold Irradiance (2) SD5600-001, SD5610-001	E _{eT(+)}			2.50	mW/cm ²	Vcc=5 V T _A =25°C
Hysteresis (3)	HYST	5		30	%	
Supply Current	lcc			12.0 15.0	mA	Ee=0 Or 3.0 mW/cm² Vcc=5 V Vcc=16 V
High Level Output Voltage SD5600 SD5610	Vон	2.4 2.4			V	V _{CC} =5 V, I _{ОН} =0 E _E =0 E _E =3.0 mW/cm²
Low Level Output Voltage SD5600 SD5610	VoL			0.4 0.4	V	V _{CC} =5 V, I _{OL} =12.8 mA E _E =0 E _E =3.0 mW/cm ²
Internal Pull-Up Resistor	RINT	5.0	10.0	20.0	kΩ	
Operate Point Temperature Coefficient	Ортс		-0.76		%/°C	Emitter @ Constant Temperature
Output Rise Time	t _r		60		ns	R _L =390 Ω, C _L =50 pF
Output Fall Time	tf		15		ns	R _L =390 Ω, C _L =50 pF
Propagation Delay, Low-High, High-Low	t _{PLH} , t _{PHL}		5.0		μs	R _L =390 Ω, C _L =50 pF
Clock Frequency				100	kHz	R _L =390 Ω , C _L =50 pF

18 mA

260°C

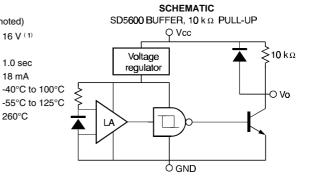
ABSOLUTE MAXIMUM RATINGS

(25°C Free-Air Temperature unless otherwise noted) Supply Voltage 16 V (1) Duration of Output

Output Current Operating Temperature Range Storage Temperature Range Soldering Temperature (10 sec)

Short to V_{CC} or Ground

1. Derate linearly from 25°C to 7 V at 100°C.



Honeywell reserves the right to make changes in order to improve design and supply the best products possible. Honeywell

Notes

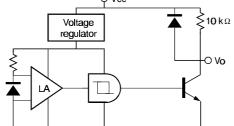
1. It is recommended that a bypass capacitor, 0.1 µF typical, be added between V_{CC} and GND near the device in order to stabilize The radiation source is an IRED with a peak wavelength of 935 nm.
 Hysteresis is defined as the difference between the operating and release threshold intensities, expressed as a percentage of the

operate threshold intensity.

Optoschmitt Detector

SCHEMATIC

SCH_013.cdr SD5610 INVERTER, 10 k Ω PULL-UP **≥10** kΩ



GND

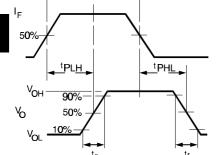
SWITCHING TIME TEST CIRCUIT

cir_007.cdr 1**00**Ω V_{IN}> 0-10 V IRED 3**90**Ω I_F100 mA peak input pulse Device un**de**r test VOUT **PGND 100**Ω ∙01.1 VO

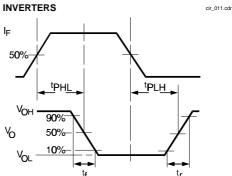
> Includes all strays & scope probe

SWITCHING WAVEFORM FOR BUFFERS

cir 013.cdr



SWITCHING WAVEFORM FOR





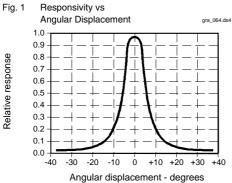
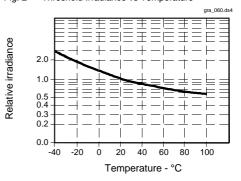


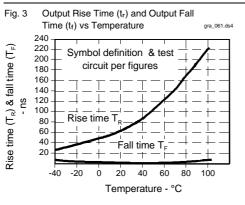
Fig. 2 Threshold Irradiance vs Temperature



Honeywell

Honeywell reserves the right to make changes in order to improve design and supply the best products possible.

Optoschmitt Detector



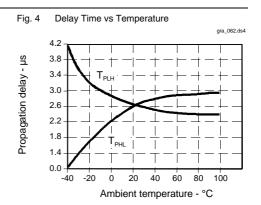
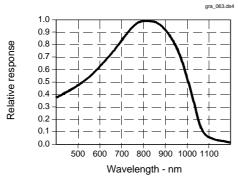


Fig. 5 Spectral Responsivity



All Performance Curves Show Typical Values